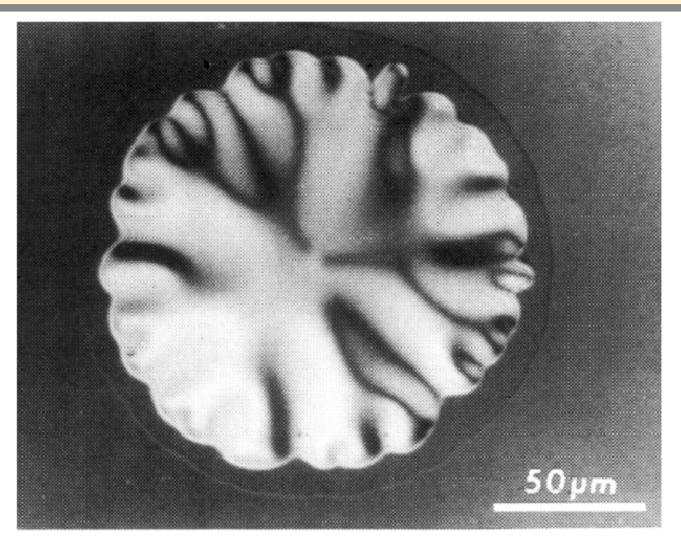
# Delamination of Compressed Thin Films

## Michael Ortiz Caltech

Material Interfaces and Geometrically Based Motions IPAM/UCLA, April 26, 2001

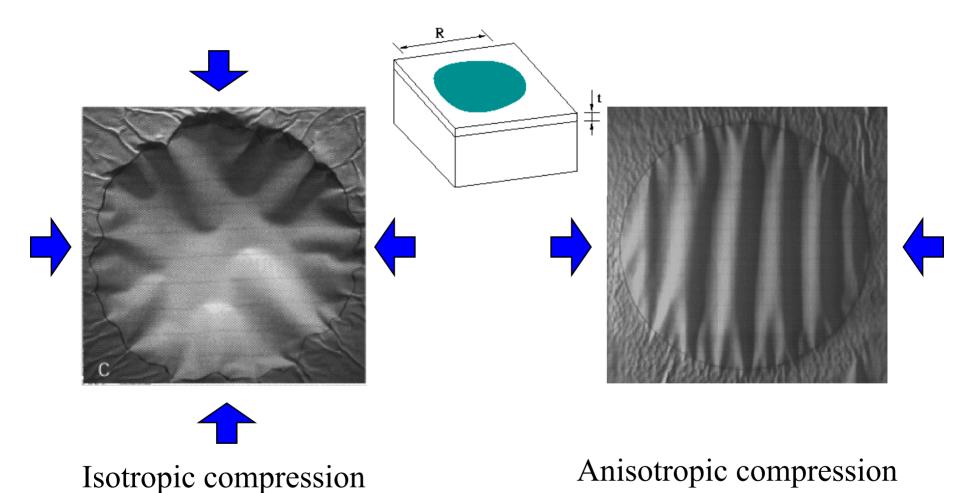






Blister in SiC film on Si substrate (Argon et al., 1989)

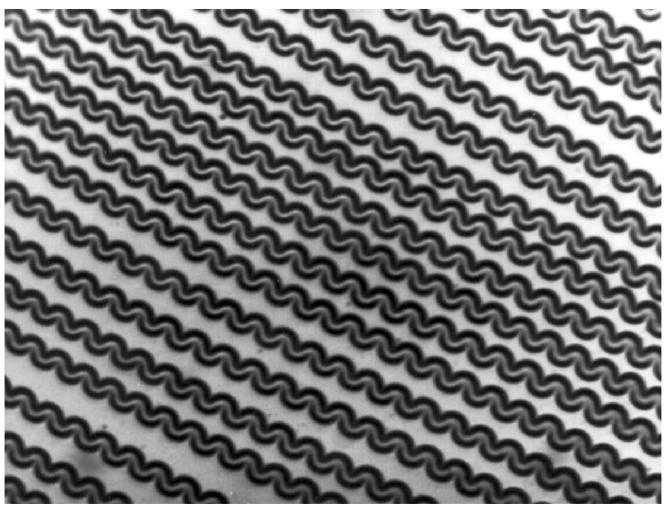
## Folding Pattern – Anisotropy



15 THE ON THE OWNER OF THE OWNER OWNER

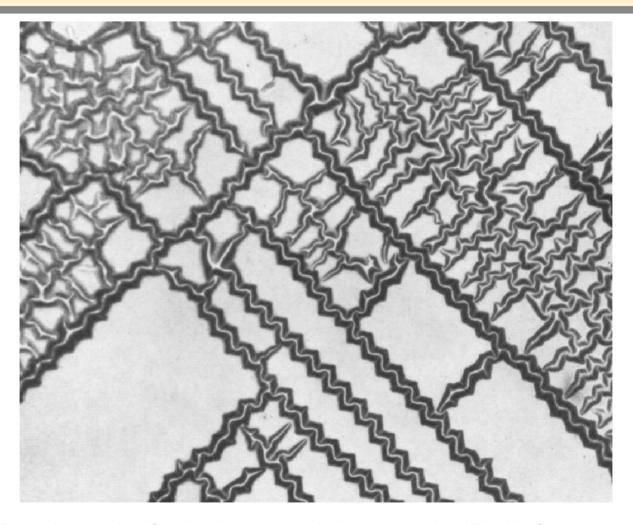
(Cuitino and Gioia, unpublished)

## **Blister Morphology**



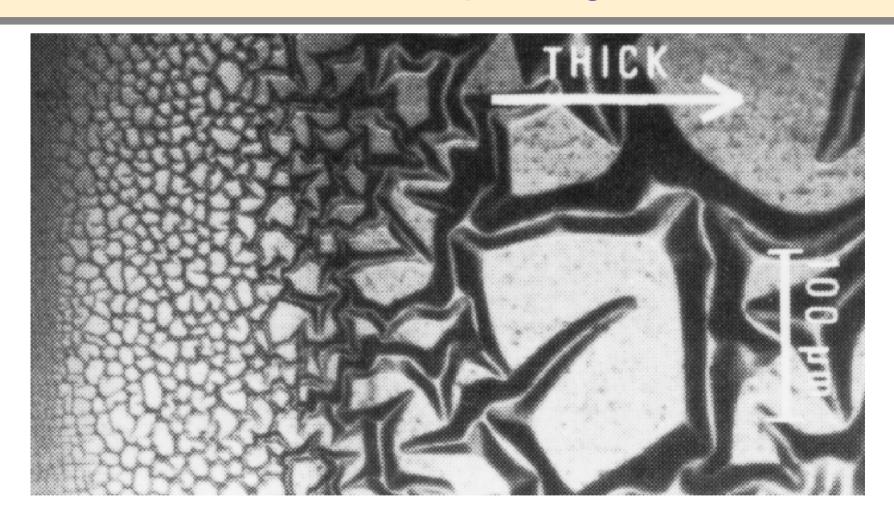


Parallel array of telephone-cord blisters (Bastawros and Kim, 1994).



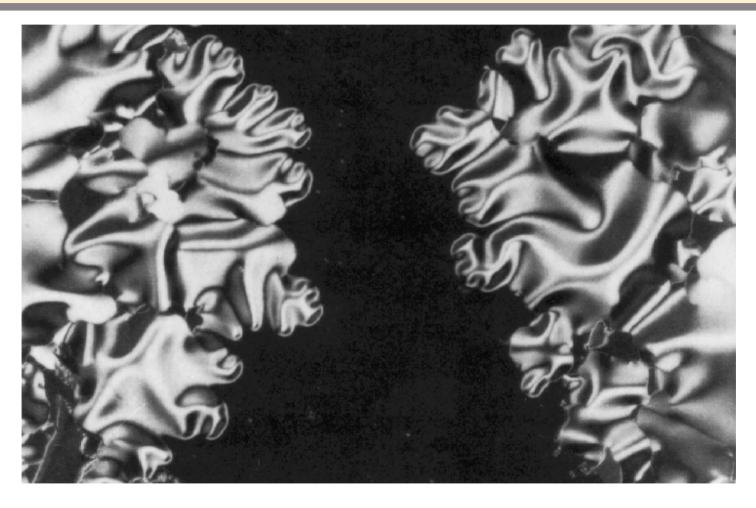


Regular web of telephone cords in a 75--25~Fe-Ni film grown by epitaxial evaporation on rock salt. (Yelon and Voegeli, 1964).



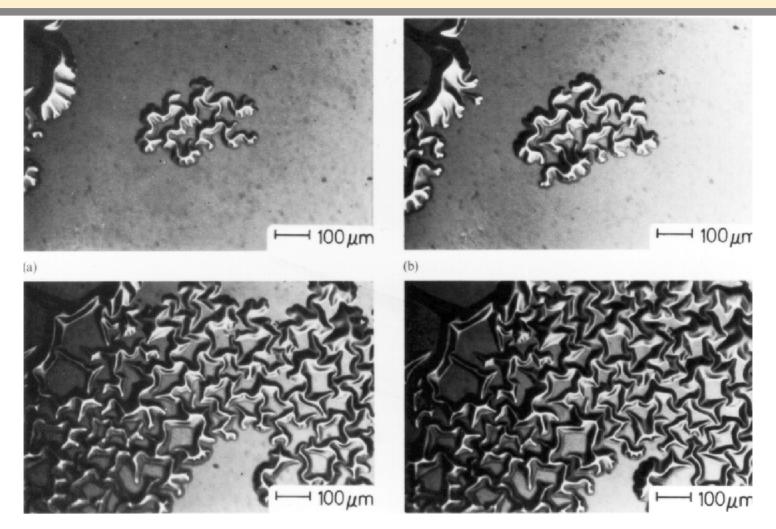


Web of blisters in a carbon film with a thickness gradient (Matuda et al., 1981)



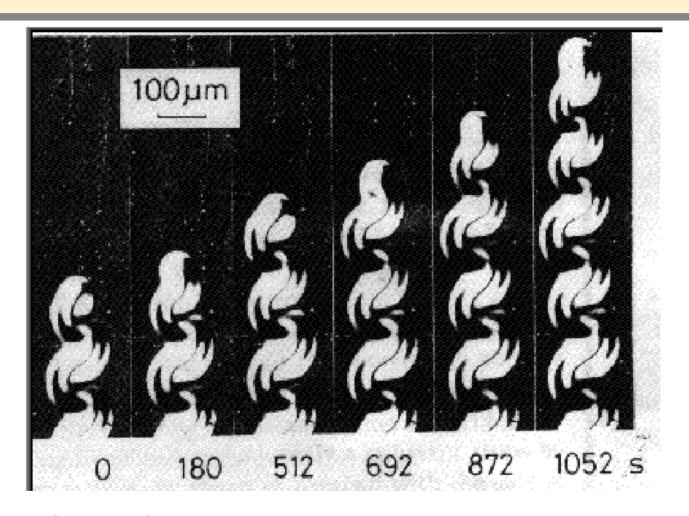


Buckling fronts in a 0.6 micron diamond-like carbon film advancing over Si substrate (Seth et al., 1992)





Web of blisters in an 800~\AA~carbon film on a glass substrate (Kinbara et al., 1981). a) 2~h; b) 4~h; c) 10~h; and d) 12~h.



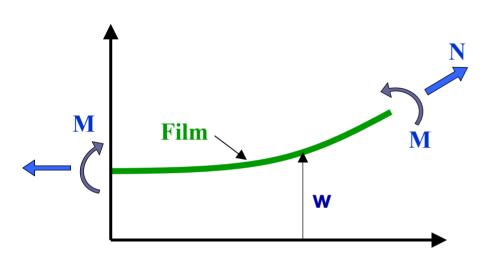


Growth of a telephone-cord blister in a Mo/glass system by delamination at the tip (Ogawa et al., 1986).

### Questions

- What are the preferred folding patterns of blisters?
- What are the preferred shapes of blisters?
- What are the growth modes, rates, of blisters?
- Ortiz, M. and Gioia, G. ``The Morphology and Folding Patterns Of Buckling
   Driven Thin-Film Blisters," J. Mech. Phys. Solids, 42 (1994) 531-559.
- Gioia, G. and Ortiz, M., ``Delamination of Compressed Thin Films," *Adv. Appl. Mech.*, **33** (1997) 119-192.
- Cuitino, A.M., Gioia, G., DeSimone, A. and Ortiz, M. ``Folding Energetics in Thin-Film Diaphragms," TAM Report #939, UIUC, April, 2000.
- Cirak, F., Cuitino, A.M., Gioia, G., Ortiz, M., Smart, M. ``A Numerical Study
  of Anisotropically Compressed Thin-Film Diaphragms," ASME/WAM,
   Orlando, FL, November, 2000.

## Von Karman Theory of plate bending



Kinematics

$$arepsilon_{lphaeta}=w,_{lpha}w,_{eta}/2-arepsilon_{lphaeta}^{*}$$
  $\chi_{lphaeta}=w,_{lphaeta}$  Eigenstrains

• Isotropic compression:



$$\varepsilon_{\alpha\beta}^* = \varepsilon^* \delta_{\alpha\beta}$$

Energy of the film:

$$\Phi[w] = \Phi^{\mathsf{m}}[w] + \Phi^{\mathsf{b}}[w]$$

Membrane energy:

$$\Phi^{\rm m}[w] = \int_{\Omega} \frac{C}{8} (|\nabla w|^2 - k^2)^2 d^2x$$

$$k = \sqrt{2(1+\nu)\varepsilon^*}$$
 (Preferred slope)

Bending energy:  $\Phi^{\mathrm{b}}[w] =$ 

$$\int_{\Omega} \frac{D}{2} [(1-\nu)w,_{\alpha\beta}w,_{\alpha\beta} + \nu(w,_{\gamma\gamma})^2] d^2x$$

• Problem:  $\inf \Phi[w]$ 

$$w=0, w,_n=0 \text{ on } \Gamma$$

#### Thin-film limit

Membrane and bending energies:

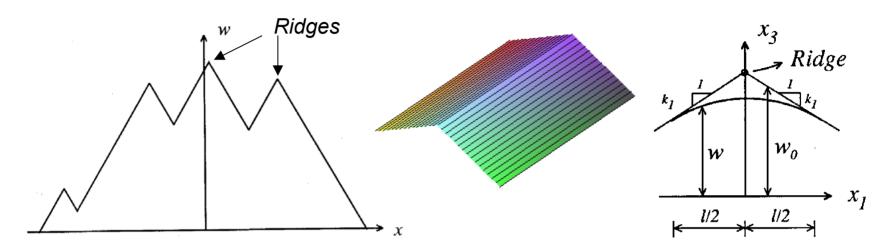
$$\Phi^{m}[w] = \int_{\Omega} \frac{C}{8} (|\nabla w|^{2} - k^{2})^{2} d^{2}x \longrightarrow C = \frac{Eh}{1 - \nu^{2}},$$

$$\Phi^{b}[w] = \int_{\Omega} \frac{D}{2} [(1 - \nu)w_{,\alpha\beta} w_{,\alpha\beta} + \nu(w_{,\gamma\gamma})^{2}] d^{2}x \longrightarrow D = \frac{Eh^{3}}{12(1 - \nu^{2})}$$

- As h→ 0, bending energy singularly perturbs membrane energy.
- Membrane problem:  $\inf \Phi^{\mathbf{m}}[w] \Rightarrow \boxed{|\nabla w| = k}$  eikonal equation Nonconvex!



## Ridge energy



- Ridge energy per unit length:  $\frac{\Phi}{L} = \frac{2}{3}\sqrt{CD}k_1^3$
- Conjecture: Let  $|\nabla w| = k \ a. \ e. \ in \ \Omega$

$$\Phi_0[w] = \Gamma - \lim_{h \to 0} \Phi[w] = \int_{\Omega} \frac{1}{3} \sqrt{CD} |w_{,\alpha\beta}| w_{,\alpha} w_{,\beta} |d^2x|$$



Energy concentrated on singular set (ridges)

 Jin and Kohn, J Nonlinear Sci, Vol 10 (2000) 355: Sharp bounds support conjecture.

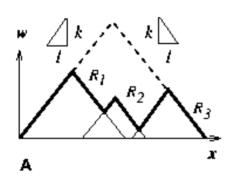
Michael Ortiz

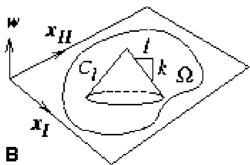
## Gamma-Limit problem

Limiting energy: Let

$$\Phi_0[w] = \Gamma - \lim_{h \to 0} \Phi[w] = \int_{\Omega} \frac{1}{3} \sqrt{CD} |w_{,\alpha\beta}| w_{,\alpha} w_{,\beta} |d^2x|$$

- Limiting problem:  $\inf \Phi_0[w]$ , subject to  $|\nabla w| = k \ a. \ e. \ in \ \Omega$
- Conjecture (Ortiz and Gioia, 1994):  $w(\mathbf{x}) = d(\mathbf{x}, \Gamma)$ Sand-heap construction!

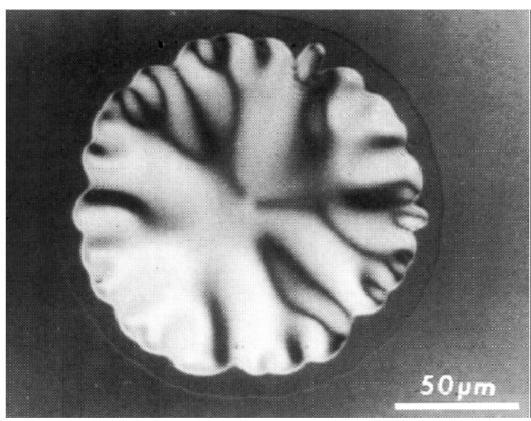


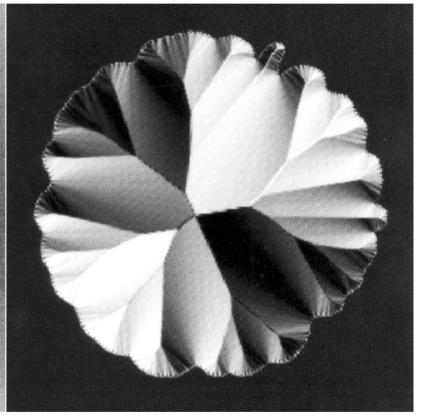


Jin and Kohn, J Nonlinear Sci, Vol 10 (2000) 355: Other constructions may deliver same energy



#### **Membrane Solution**





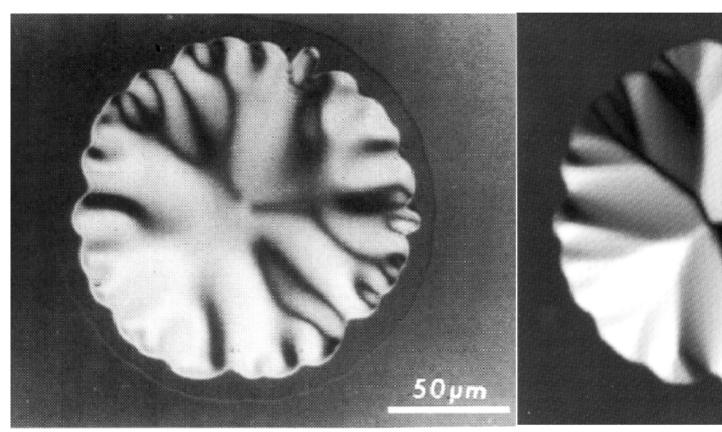
(a)

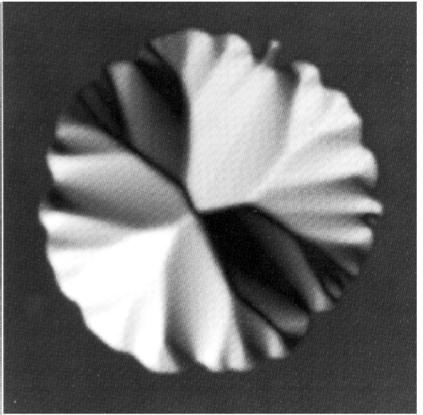
(b)

- a) Blister in SiC/Si (Argon et al., 1989)
- b) Membrane solution (Ortiz and Gioia, 1994)



## **Bending Solution**





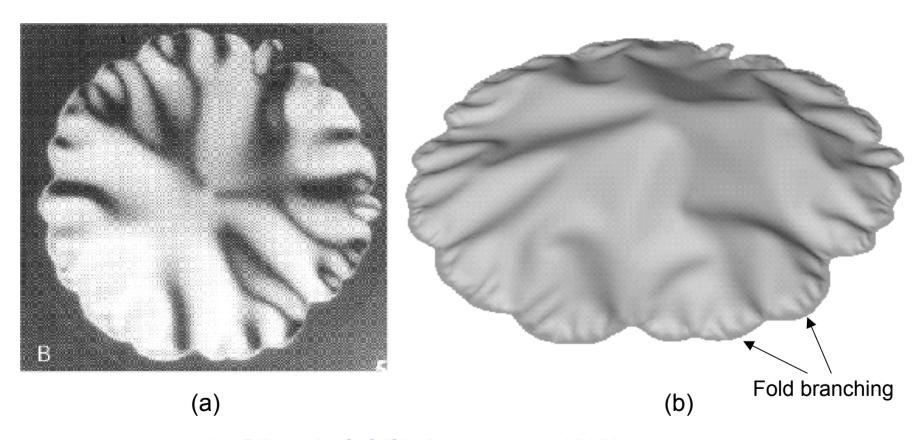
(a) (b)



- a) Blister in SiC/Si (Argon et al., 1989)
- b) Membrane solution (Ortiz and Gioia, 1994)

Michael Ortiz

#### Finite-deformation shell solution





- a) Blister in SiC/Si (Argon et al., 1989)
- b) Finite-deformation shell solution (Cirak, Ortiz, Gioia, Smart and Cuitino, 2000)

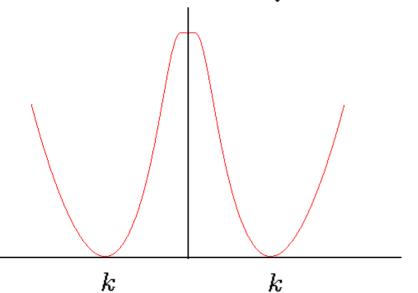
Michael Ortiz

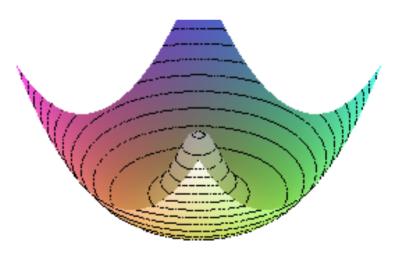
## Membrane minimizers - Isotropic

•Isotropic compression:  $\epsilon_I^* = \epsilon_{II}^*$ 

$$|\nabla w| = k$$
, where  $k \equiv \sqrt{2(\epsilon_I^* + \nu \epsilon_{II}^*)}$ 

compressive regime,  $\epsilon_I^* > 0$ 





Membrane energy density

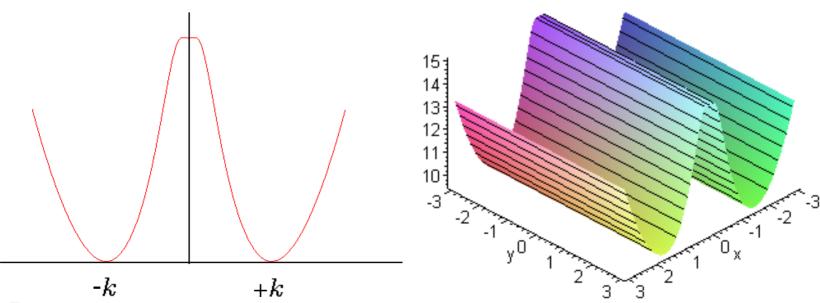


## Membrane minimizers - Anisotropic

•Anisotropic compression:  $\epsilon_I^* \neq \epsilon_{II}^*$ 



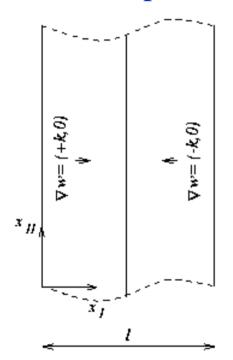
compressive regime,  $\epsilon_I^* + \nu \epsilon_{II}^* > 0$ 

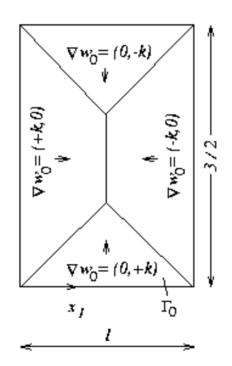


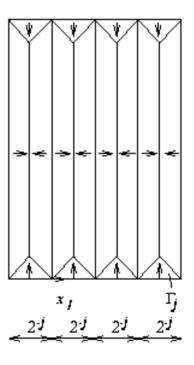


## Membrane construction - Anisotropic

#### Anisotropic compression: $\epsilon_I^* \neq \epsilon_{II}^*$





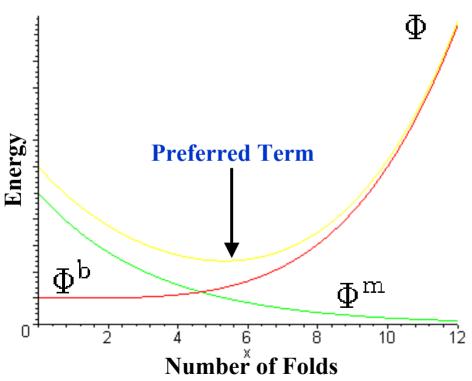




 $\Phi^m$  can be driven arbitrarily close to its infimum by allowing the diaphragm to develop fine folding

## Gamma-limit construction - Anisotropic

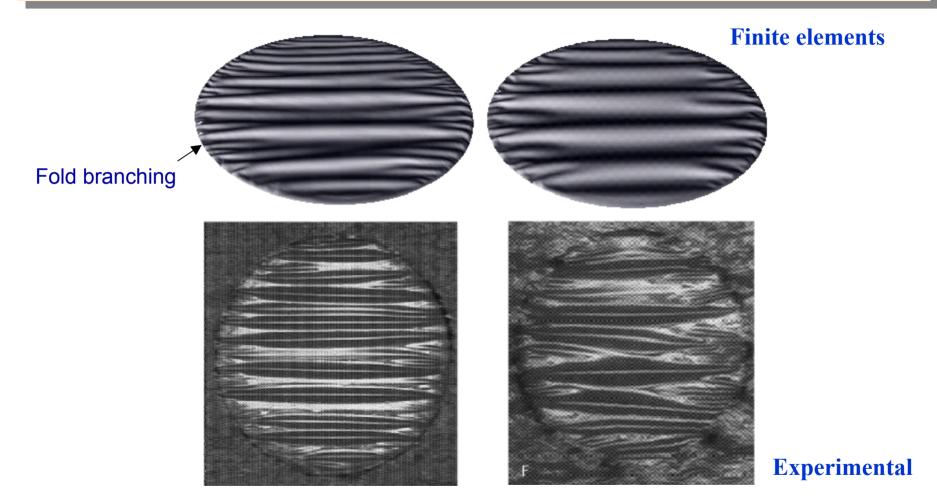
#### **ANISOTROPIC** $\epsilon_I^* \neq \epsilon_{II}^*$



#### **Implications**

- No folding exist which ca accommodate the boundary conditions and minimize  $\Phi^m$
- The infimum of  $\Phi^m$  can be approached by allowing the folding to increase without limit (minimizing sequence)
- Bending selects a preferred folding





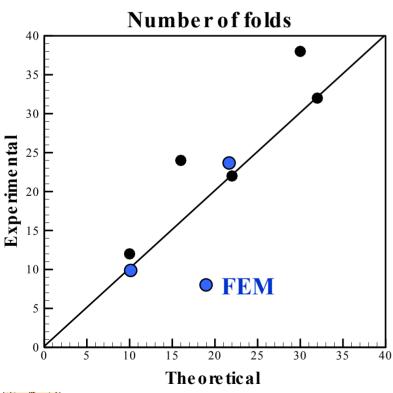


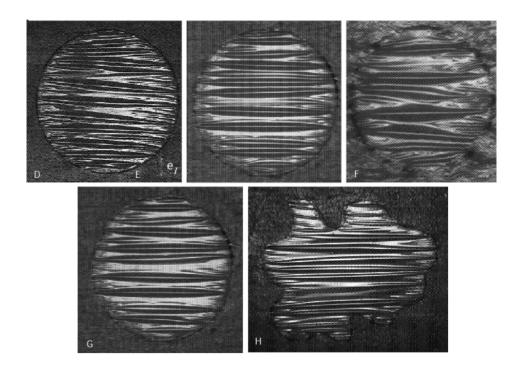
Belgacem, Conti, DeSimone and Muller, J. Nonlinear Sci, 10 (2000) 661: Fold branching delivers optimal energy scaling.

Michael Ortiz

#### **Anisotropic compression**

**Number of folds:** N ~ d/h  $(\varepsilon^*)^{1/2}$ 

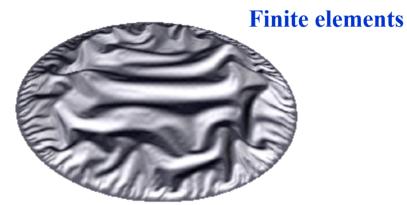




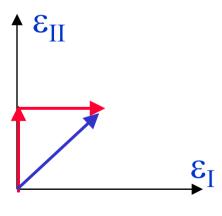


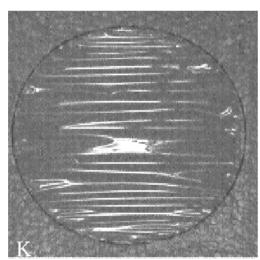
## Path-dependence - Metastability

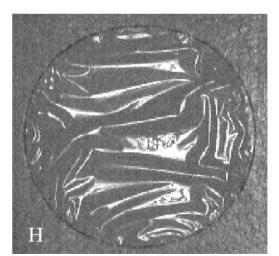




#### **Path Dependence**





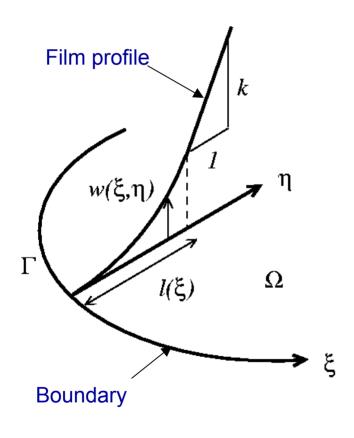


**Experimental** 



Michael Ortiz

#### **Delamination kinetics**



**Boundary layer geometry** 

 Configurational (driving) force for delamination:

$$G = \frac{D}{2}\chi^2$$

Bending strain:

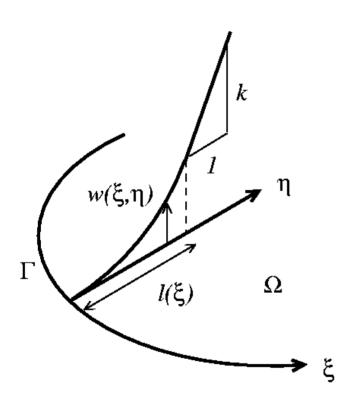
$$\chi = w_{,\eta\eta}$$

Kinetic growth law:

$$v = \begin{cases} (G - G_c)/B & \text{if } G > G_c \\ 0 & \text{otherwise} \end{cases}$$



## Boundary-layer analysis



Boundary-layer energy:

$$\Phi[\chi] = \int_0^L T(\kappa, \kappa'; \chi, \chi', \chi'') \, d\xi$$

Boundary-layer equilibrium

$$f(\kappa, \kappa', \kappa'', \kappa'''; \chi, \chi', \chi'', \chi''', \chi^{iv}) \equiv \frac{\partial T}{\partial \chi} - \frac{d}{d\xi} \frac{\partial T}{\partial \chi'} + \frac{d^2}{d\xi^2} \frac{\partial T}{\partial \chi''} = 0$$

Everywhere critical boundary:

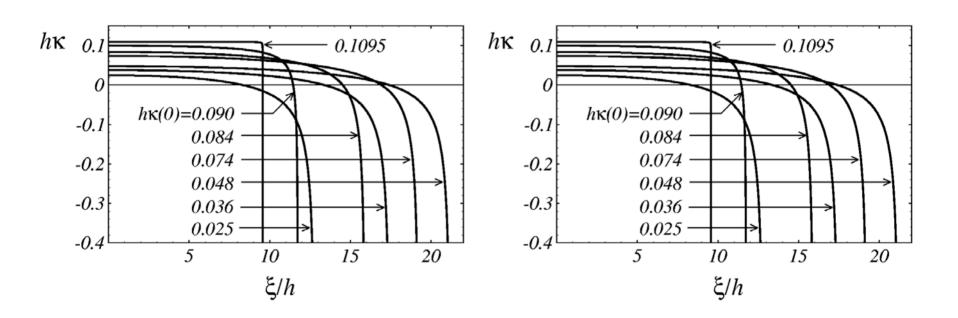
$$G = G_c \quad \text{on } \Gamma$$

$$f(\kappa, \kappa', \kappa'', \kappa'') = 0$$



Equation for boundary curvature as a function of arc length (shape)

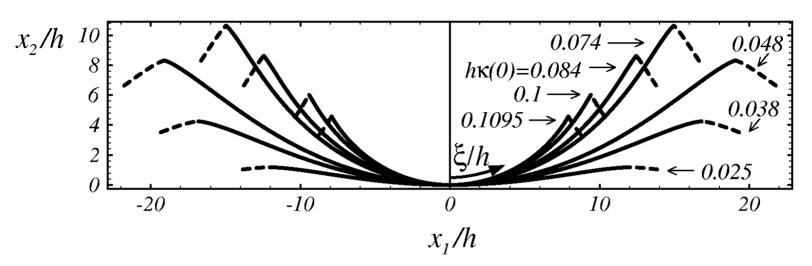
## Everywhere-critical boundary shapes



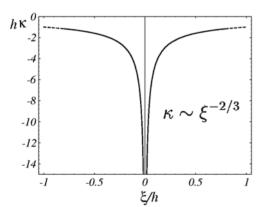
Boundary curvature and tangent angle as a function of arc length

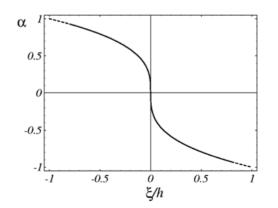


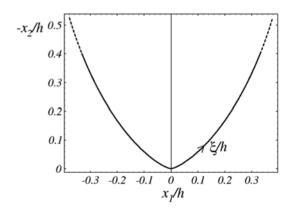
## Everywhere-critical boundary shapes



#### Geometry of everywhere-critical boundary



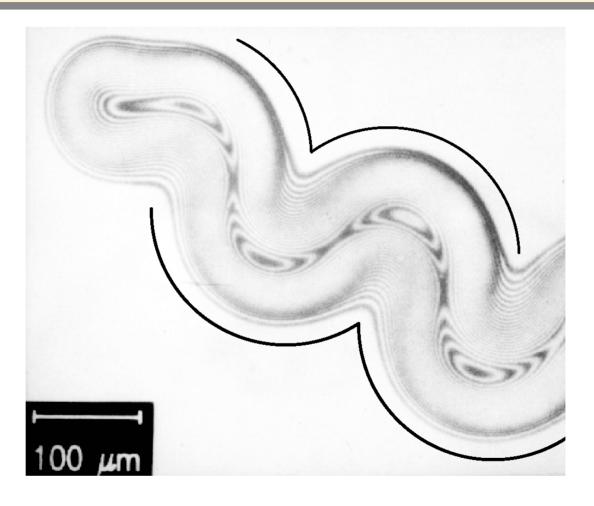






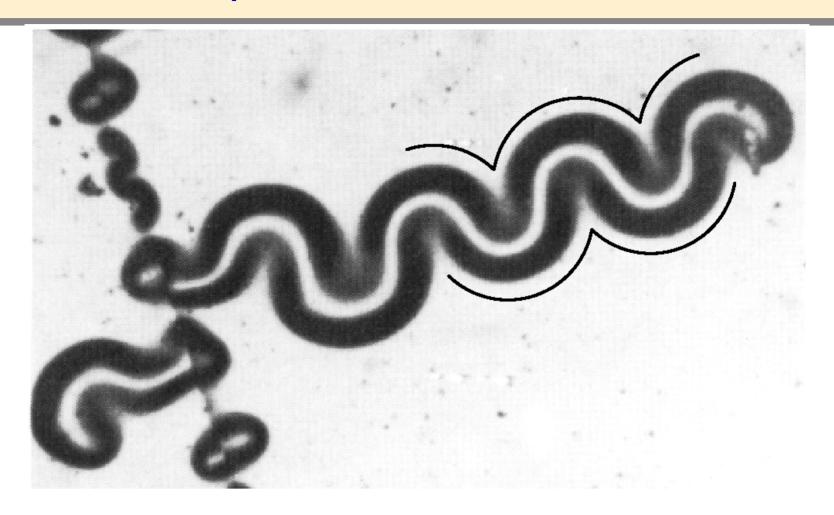
Cusp geometry

Michael Ortiz





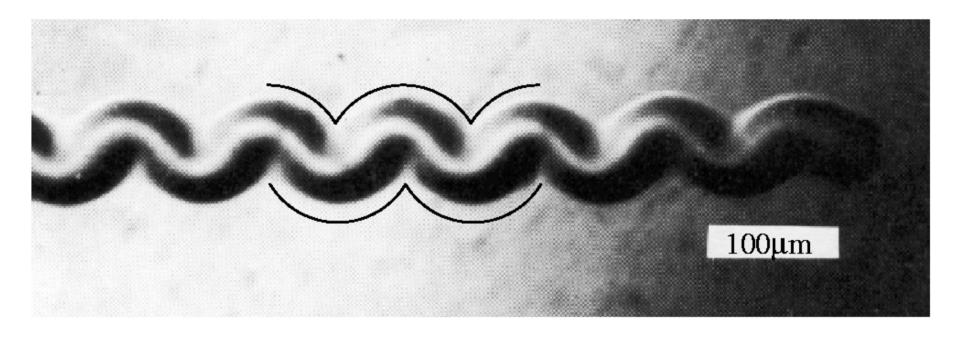
Comparison of telephone cord in a Si/SiO2~glass system reported by Thouless (1993) and boundary shape predicted by theory (Gioia and Ortiz, 1997)



Comparison of telephone cord in a diamond-like carbon/glass system reported by

Nir (1984) and boundary shape predicted by theory (Gioia and Ortiz, 1997).

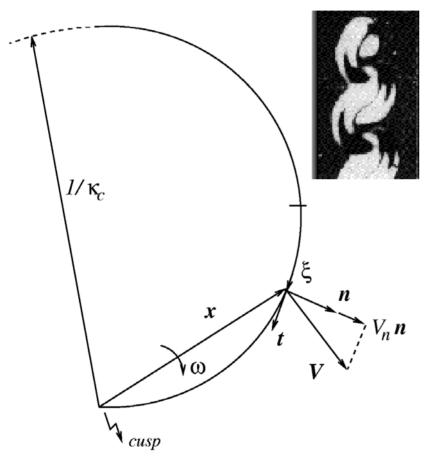
Michael
Ortiz



Comparison of telephone cord in a compositionally modulated Fe/Ni film reported by Yu, Kim and Sanday (1991) and boundary shape predicted by theory (Gioia and Ortiz, 1997)



## Telephone-cord growth



Kinetic growth law:

$$v = \begin{cases} (G - G_c)/B & \text{if } G > G_c \\ 0 & \text{otherwise} \end{cases}$$

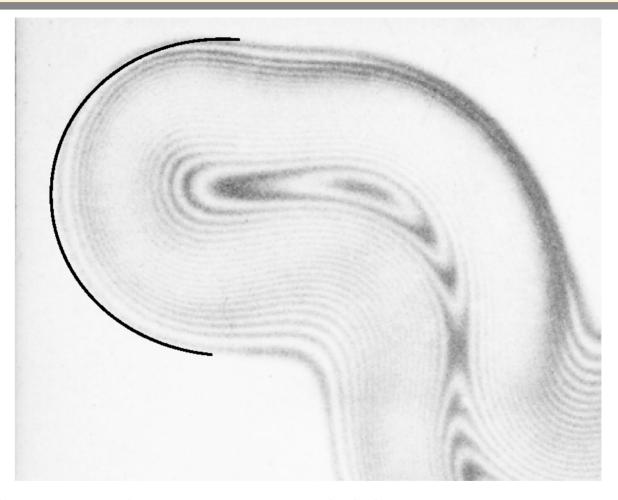
Governing equation:

$$2\kappa'' + \kappa(\kappa^2 - \kappa_c^2) = 0$$

General solution:

$$\xi = \int_{\kappa_0}^{\kappa} \frac{2d\kappa}{\sqrt{(\kappa_0^2 - \kappa_c^2)^2 - (\kappa^2 - \kappa_c^2)^2}}$$







Comparison of telephone cord in a Si/SiO2~glass system reported by Thouless (1993) and tip shape predicted by the theory (Gioia and Ortiz, 1997)

"You have delighted us long enough!"

(Pride and Prejudice, Jane Austen)

